

# MT30033S

## N-Channel Power MOSFET

30 V, 100 A, 3.3 mΩ

### Features

- Typ  $R_{DS(on)} = 3.3\text{ m}\Omega$  at  $V_{GS} = 10\text{ V}$ ,  $I_D = 10\text{ A}$
- High performance trench technology for extremely low  $R_{DS(on)}$
- High power and current handling capability

### General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $R_{DS(ON)}$  and fast switching speed.

### Applications

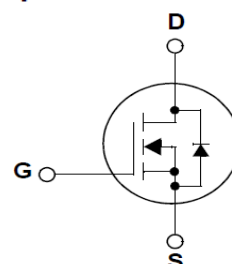
- DC-DC primary bridge
- DC-DC Synchronous rectification
- Power Management for Inverter Systems



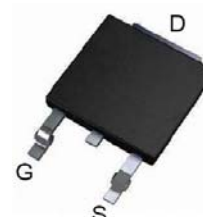
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### Simplified Schematic



### MARKING DIAGRAM & PIN ASSIGNMENT



TO-252-2L

## Absolute Maximum Ratings

| Symbol   | Parameter                              |                       | Rating     | Unit |
|--|--|-----------------------|------------|------|
| Common Ratings (T <sub>A</sub> =25°C Unless Otherwise Noted) |  |                       |            |      |
| V <sub>DSS</sub>   | Drain-Source Voltage                   |                       | 30         | V    |
| V <sub>GSS</sub>   | Gate-Source Voltage                    |                       | ±20        |      |
| T <sub>J</sub>   | Maximum Junction Temperature           |                       | 150        | °C   |
| T <sub>STG</sub>   | Storage Temperature Range              |                       | -55 to 150 | °C   |
| I <sub>S</sub>   | Diode Continuous Forward Current       | T <sub>C</sub> =25°C  | 100        | A    |
| Mounted on Large Heat Sink                                   |  |                       |            |      |
| I <sub>DM</sub>  | Pulsed Drain Current *                 |                       | 300        | A    |
| I <sub>D</sub>   | Continuous Drain Current               | T <sub>C</sub> =25°C  | 100        | A    |
|  |  | T <sub>C</sub> =100°C | 70         |      |
| P <sub>D</sub>   | Maximum Power Dissipation              | T <sub>C</sub> =25°C  | 50         | W    |
|  |  | T <sub>C</sub> =100°C | 35         |      |
| R <sub>θJC</sub>   | Thermal Resistance-Junction to Case    |                       | 1.3        | °C/W |
| R <sub>θJA</sub>   | Thermal Resistance-Junction to Ambient |                       | 32.5       |      |
| Avalanche Ratings  |  |                       |            |      |
| E <sub>AS</sub>  | Avalanche Energy, Single Pulsed        | L=0.5mH               | 220***     | mJ   |

## Electrical Characteristics (T<sub>A</sub> = 25°C Unless Otherwise Noted)

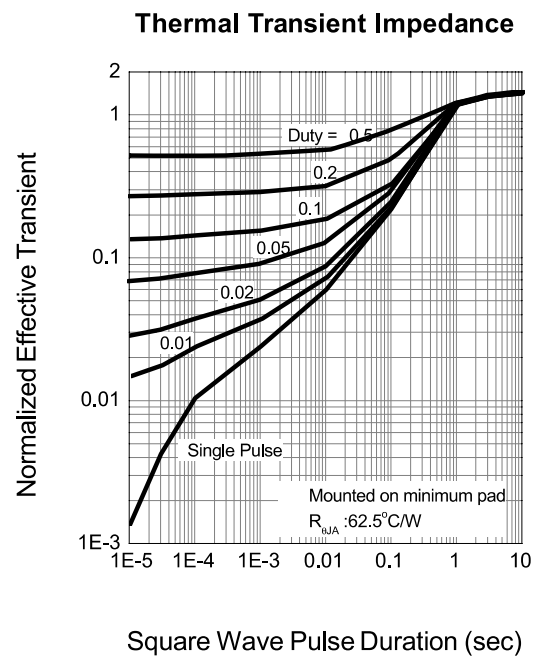
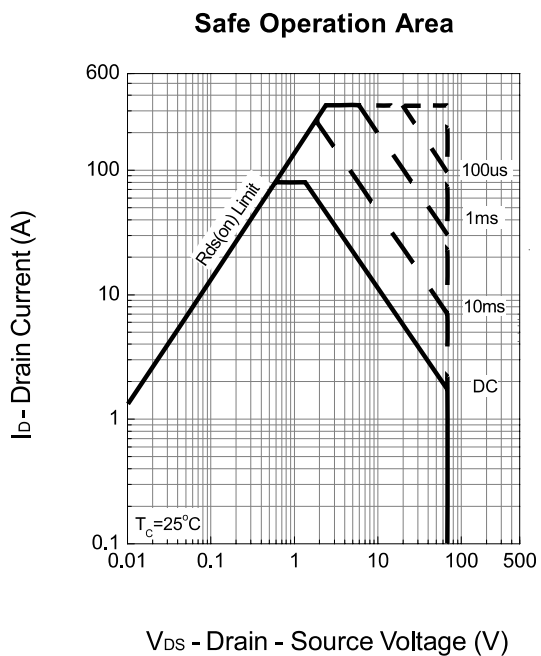
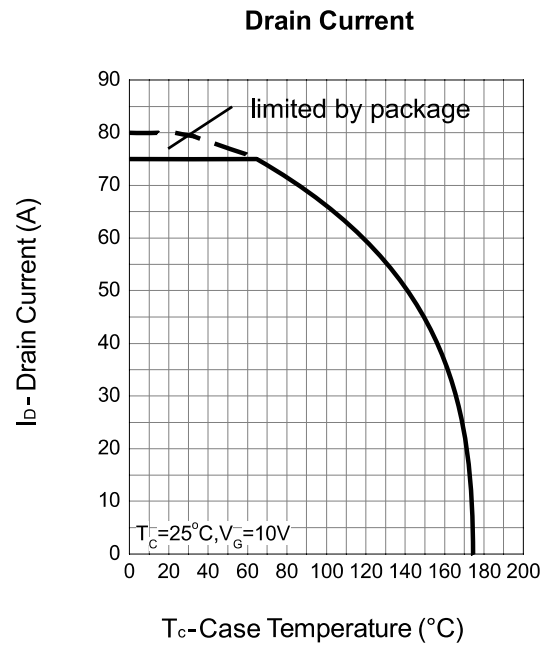
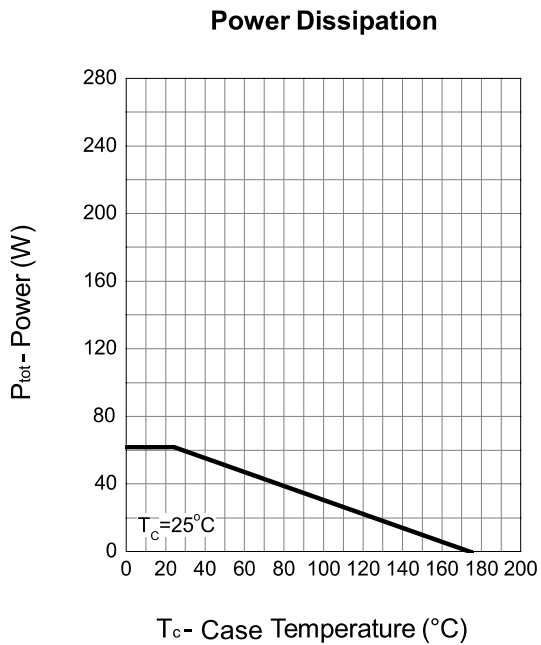
| Symbol                 | Parameter                        | Test Conditions   |      |      |      | Unit |
|------------------------|----------------------------------|---|------|------|------|------|
|                        |                                  |   | Min. | Typ. | Max. |      |
| Static Characteristics |                                  |   |      |      |      |      |
| BV <sub>DSS</sub>      | Drain-Source Breakdown Voltage   | V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA               | 30   | -    | -    | V    |
| I <sub>DSS</sub>       | Zero Gate Voltage Drain Current  | V <sub>DS</sub> =24V, V <sub>GS</sub> =0V                 | -    | -    | 1    | μA   |
|                        |                                  | T <sub>J</sub> =85°C                                      | -    | -    | 10   |      |
| V <sub>GS(th)</sub>    | Gate Threshold Voltage           | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA | 1    | 1.6  | 3    | V    |
| I <sub>GSS</sub>       | Gate Leakage Current             | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V                | -    | -    | ±100 | nA   |
| R <sub>DS(ON)</sub> *  | Drain-Source On-state Resistance | V <sub>GS</sub> =10V, I <sub>DS</sub> =10A                | -    | 3.3  | 4.0  | mΩ   |
| Diode Characteristics  |                                  |   |      |      |      |      |
| V <sub>SD</sub> *      | Diode Forward Voltage            | I <sub>SD</sub> =10A, V <sub>GS</sub> =0V                 | -    | 0.8  | 1.3  | V    |
| t <sub>rr</sub>        | Reverse Recovery Time            | I <sub>SD</sub> =10 A, dI <sub>SD</sub> /dt=100A/μs       | -    | 33   | -    | ns   |
| Q <sub>rr</sub>        | Reverse Recovery Charge          |   | -    | 61   | -    | nC   |

## Electrical Characteristics (Cont.) (T<sub>A</sub> = 25°C Unless Otherwise Noted)

| Symbol                      | Parameter                    | Test Conditions   |      |      |      | Unit |
|-----------------------------|------------------------------|---|------|------|------|------|
|                             |                              |   | Min. | Typ. | Max. |      |
| Dynamic Characteristics     |                              |   |      |      |      |      |
| R <sub>G</sub>              | Gate Resistance              | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz  | -    | 1.8  | -    | Ω    |
| C <sub>iss</sub>            | Input Capacitance            | V <sub>GS</sub> =0V,<br>V <sub>DS</sub> =25V,<br>Frequency=1.0MHz                         | -    | 3203 | -    | pF   |
| C <sub>oss</sub>            | Output Capacitance           |   | -    | 362  | -    |      |
| C <sub>rss</sub>            | Reverse Transfer Capacitance |   | -    | 277  | -    |      |
| t <sub>d(ON)</sub>          | Turn-on Delay Time           | V <sub>DD</sub> =24V, R <sub>G</sub> =3 Ω,<br>I <sub>DS</sub> =40A, V <sub>GS</sub> =10V, | -    | 15   | -    | ns   |
| T <sub>r</sub>              | Turn-on Rise Time            |   | -    | 13   | -    |      |
| t <sub>d(OFF)</sub>         | Turn-off Delay Time          |   | -    | 20   | -    |      |
| T <sub>f</sub>              | Turn-off Fall Time           |   | -    | 8    | -    |      |
| Gate Charge Characteristics |                              |   |      |      |      |      |
| Q <sub>g</sub>              | Total Gate Charge            | V <sub>DS</sub> =15V, V <sub>GS</sub> =10V,<br>I <sub>DS</sub> =40A                       | -    | 84   | -    | nC   |
| Q <sub>gs</sub>             | Gate-Source Charge           |   | -    | 14   | -    |      |
| Q <sub>gd</sub>             | Gate-Drain Charge            |   | -    | 30   | -    |      |

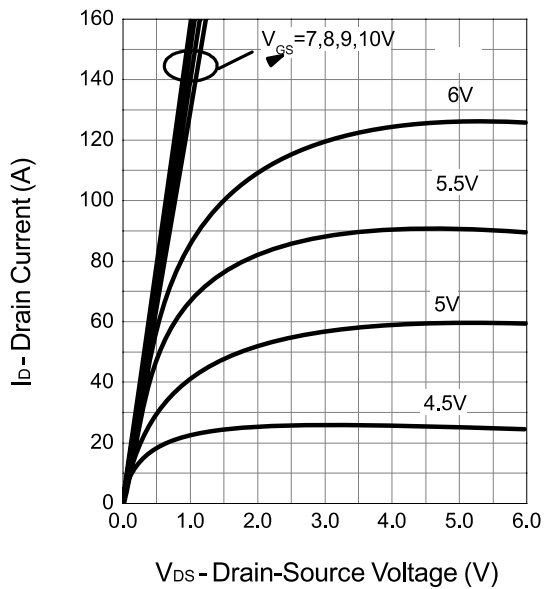
Note \* : Pulse test ; pulse width ≤ 300μs, duty cycle ≤ 2%.

## Typical Operating Characteristics

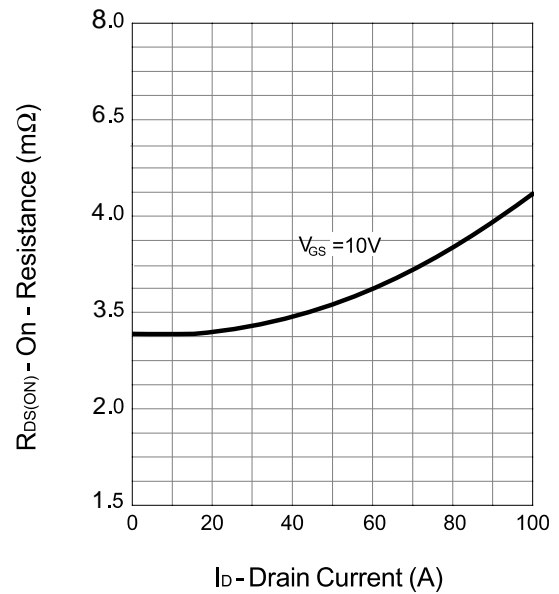


## Typical Operating Characteristics (Cont.)

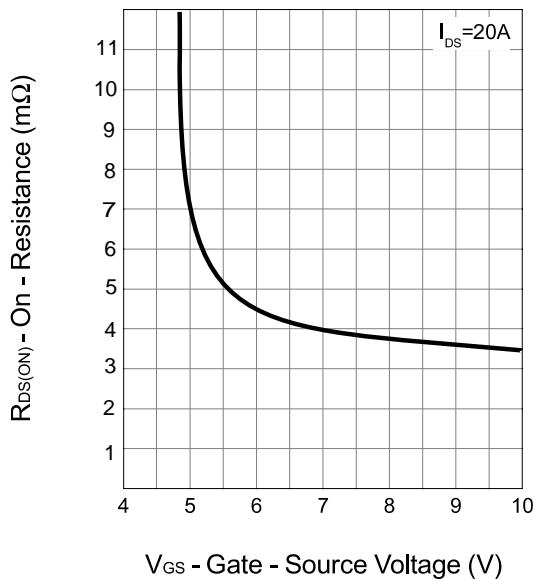
Output Characteristics



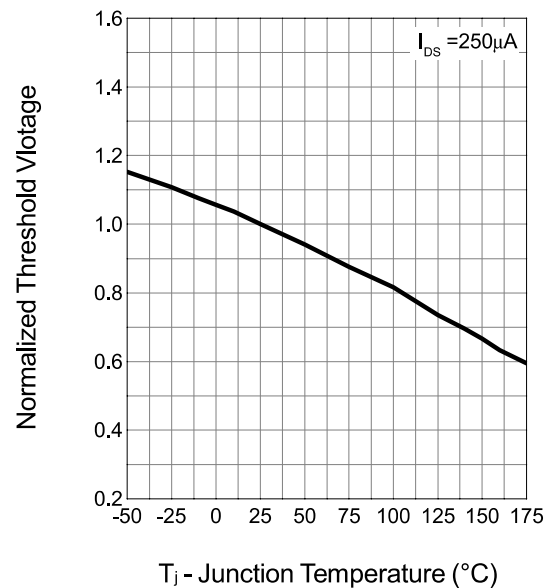
Drain-Source On Resistance



Drain-Source On Resistance

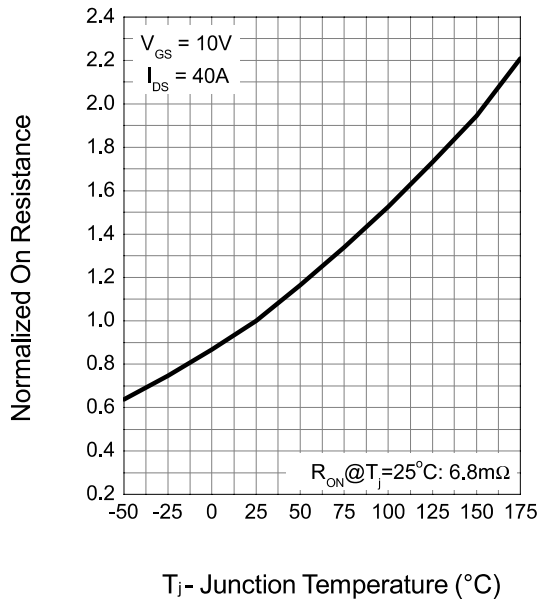


Gate Threshold Voltage

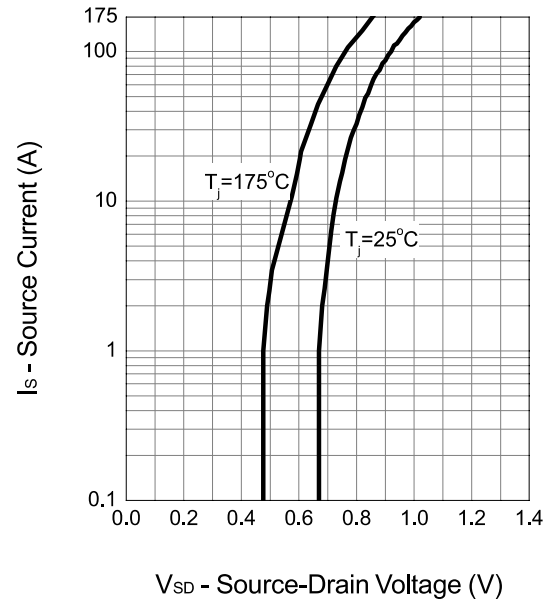


## Typical Operating Characteristics (Cont.)

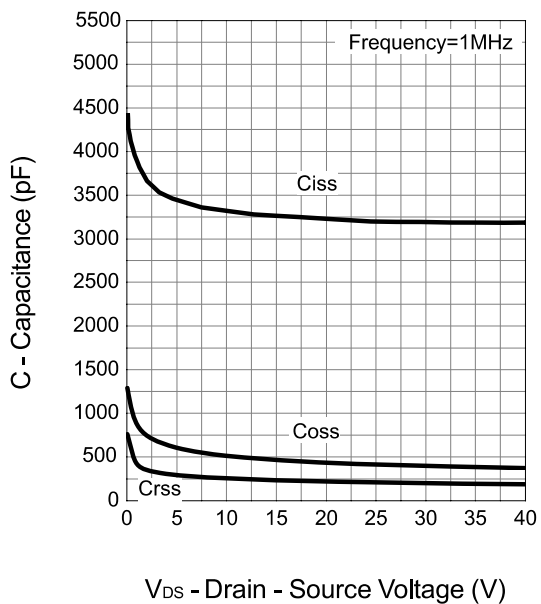
### Drain-Source On Resistance



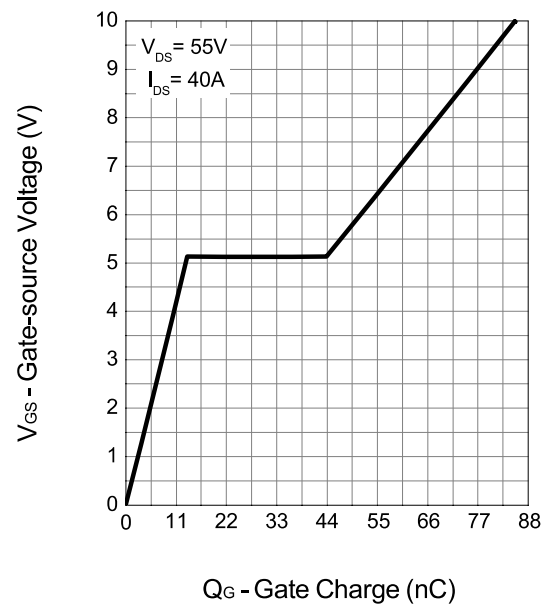
### Source-Drain Diode Forward



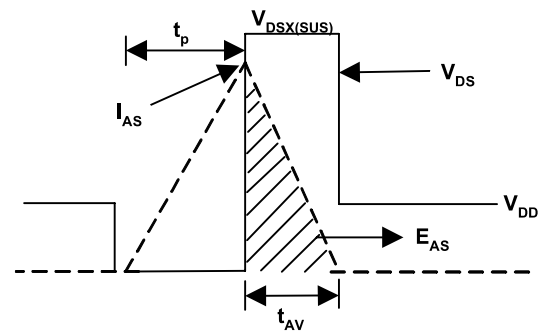
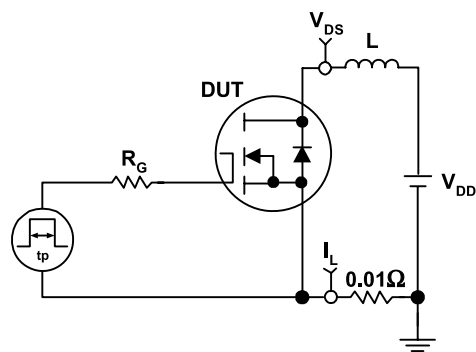
### Capacitance



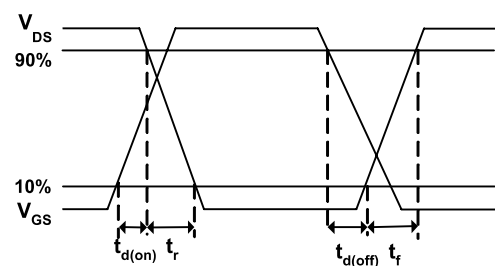
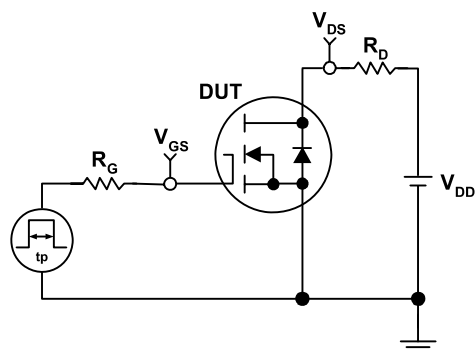
### Gate Charge



## Avalanche Test Circuit and Waveforms

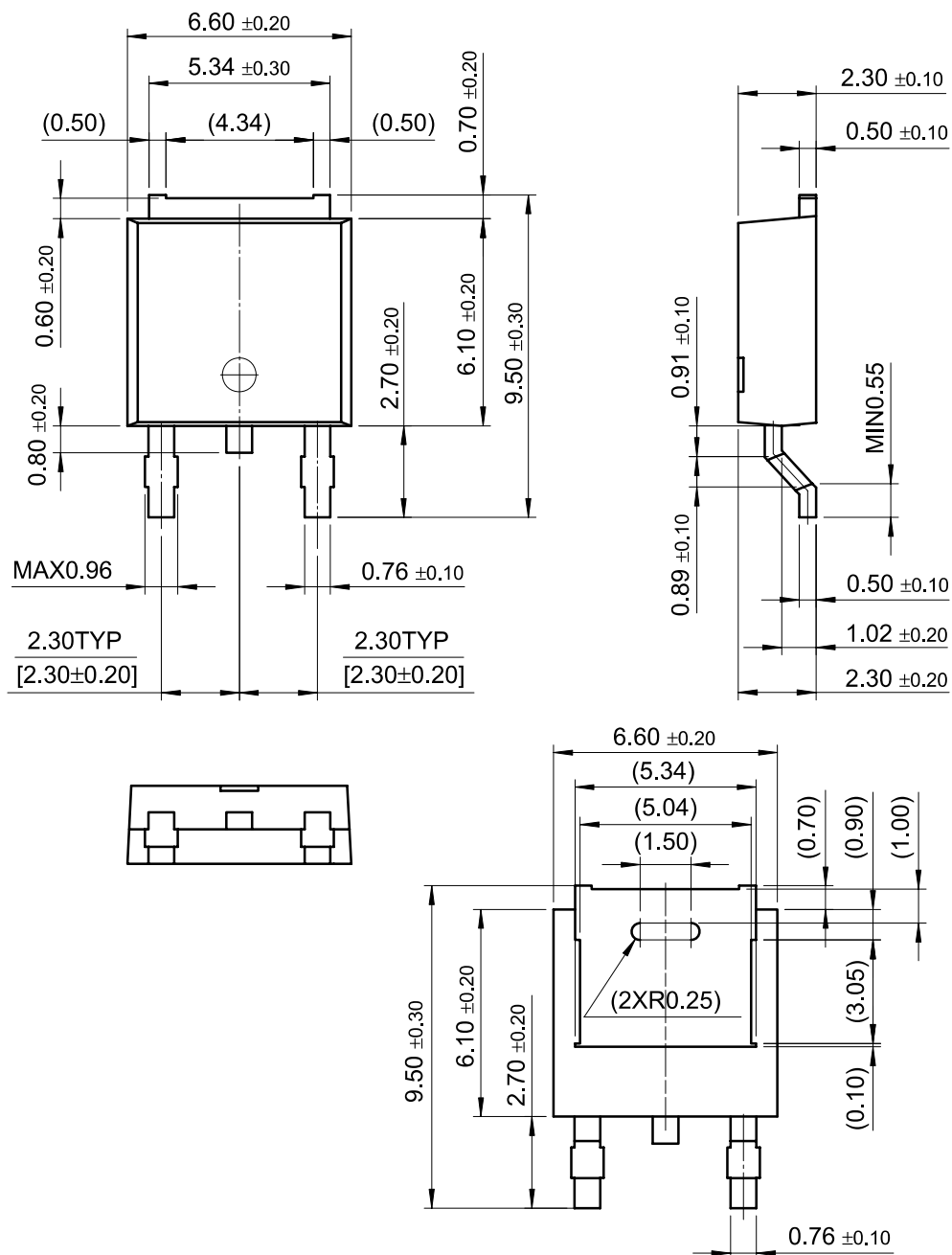


## Avalanche Test Circuit and Waveforms



## Package Dimensions

## TO-252-2L



Dimensions in Millimeters



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